30V N-CHANNEL ENHANCEMENT MODE MOSFET 2.5V GATE DRIVE

SUMMARY

 $\textit{V}_{(BR)DSS}\text{=}30\textit{V}:\textit{R}_{DS}(_{on})\text{=}0.08\Omega;\textit{I}_{D}\text{=}3.5\textit{A}$

DESCRIPTION

This new generation of Trench MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.



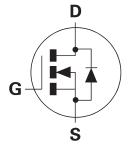
PACKAGE

FEATURES

- Low on-resistance
- · Fast switching speed
- Low threshold
- · Low gate drive
- SOT23 package

APPLICATIONS

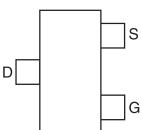
- DC-DC converters
- Power management functions
- Disconnect switches
- Motor control



ORDERING INFORMATION

DEVICE	REEL SIZE	TAPE WIDTH	QUANTITY PER REEL	
ZXMN3B14FTA	7″	8mm	3,000 units	
ZXMN3B14FTC	13″	8mm	10,000 units	





DEVICE MARKING

• 3B4

ZETEX

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DSS}	30	V
Gate-Source Voltage	V _{GS}	±12	V
	I _D	3.5 2.9 2.9	A A A
Pulsed Drain Current (c)	I _{DM}	16	А
Continuous Source Current (Body Diode) (b)	I _S	2.4	А
Pulsed Source Current (Body Diode) (c)	I _{SM}	16	А
Power Dissipation at T _A =25°C ^(a)	P _D	1	W
Linear Derating Factor		8	mW/°C
Power Dissipation at T _A =25°C (b)	P _D	1.5	W
Linear Derating Factor		12	mW/°C
Operating and Storage Temperature Range	T _j , T _{stg}	-55 to +150	°C

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient ^(a)	$R_{\Theta JA}$	125	°C/W
Junction to Ambient (b)	$R_{\Theta JA}$	83	°C/W

NOTES

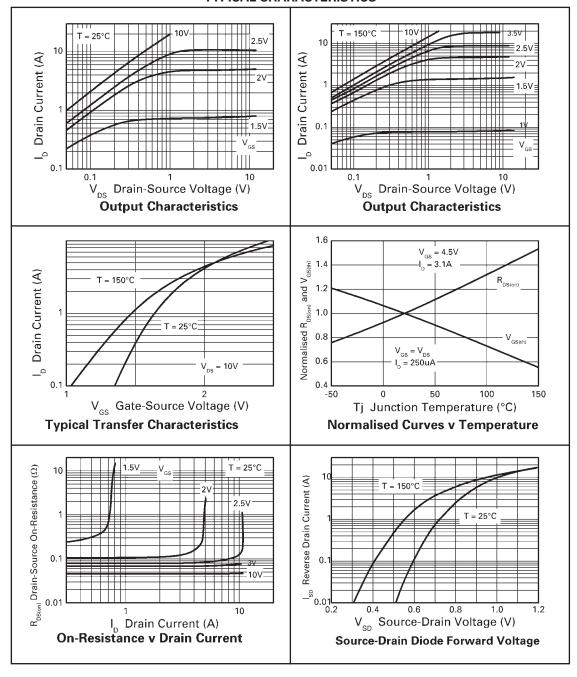


⁽a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

⁽b) For a device surface mounted on FR4 PCB measured at t \leq 5 sec.

⁽c) Repetitive rating - $25mm \times 25mm FR4$ PCB, D=0.02, pulse width $300\mu s$ - pulse width limited by maximum junction temperature.

TYPICAL CHARACTERISTICS





ELECTRICAL CHARACTERISTICS (at T_{amb} = 25°C unless otherwise stated)

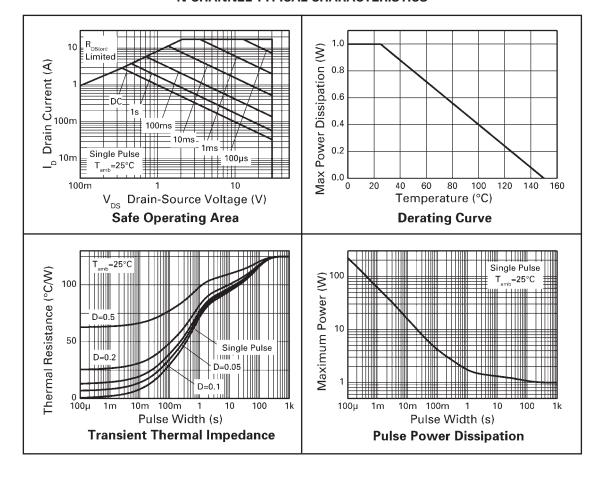
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS		
STATIC		'		-				
Drain-Source Breakdown Voltage	V _{(BR)DSS}	30			V	I _D = 250μA, V _{GS} =0V		
Zero Gate Voltage Drain Current	I _{DSS}			1	μΑ	V _{DS} = 30V, V _{GS} =0V		
Gate-Body Leakage	I _{GSS}			100	nA	V_{GS} = \pm 12V, V_{DS} =0V		
Gate-Source Threshold Voltage	V _{GS(th)}	0.7			V	I _D = 250μA, V _{DS} =V _{GS}		
Static Drain-Source On-State	R _{DS(on)}			0.080	Ω	V _{GS} = 4.5V, I _D = 3.1A		
Resistance ⁽¹⁾				0.140	Ω	$V_{GS} = 2.5V, I_{D} = 2.2A$		
Forward Transconductance (1) (3)	g _{fs}		8.5		S	V _{DS} = 15V, I _D = 3.1A		
DYNAMIC (3)	•	•						
Input Capacitance	C _{iss}		568		pF	V 45V V 0V		
Output Capacitance	C _{oss}		101		pF	V _{DS} = 15V, V _{GS} =0V		
Reverse Transfer Capacitance	C _{rss}		66		pF	f=1MHz		
SWITCHING ^{(2) (3)}	1	'						
Turn-On-Delay Time	t _{d(on)}		3.6		ns	V _{DD} = 15V, V _{GS} = 4.5V		
Rise Time	t _r		4.9		ns	$I_{D} = 15V, V_{GS} = 4.5V$		
Turn-Off Delay Time	t _{d(off)}		17.3		ns	$R_{G} \cong 6.0\Omega$		
Fall Time	t _f		9.8		ns	111G = 0.012		
Total Gate Charge	Qg		6.7		nC	V _{DS} = 15V, V _{GS} = 4.5V		
Gate-Source Charge	Q _{gs}		1.4		nC	I _D = 3.1A		
Gate Drain Charge	Q_{gd}		1.8		nC	10- 3.17		
SOURCE-DRAIN DIODE	, -	•						
Diode Forward Voltage (1)	V _{SD}		0.82	0.95	V	T _i =25°C, I _S = 3.1A,		
						V _{GS} =0V		
Reverse Recovery Time (3)	t _{rr}		10.8		ns	T _j =25°C, I _F = 1.6A,		
Reverse Recovery Charge (3)	Q _{rr}		4.54		nC	di/dt=100A/μs		

NOTES

- (1) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.

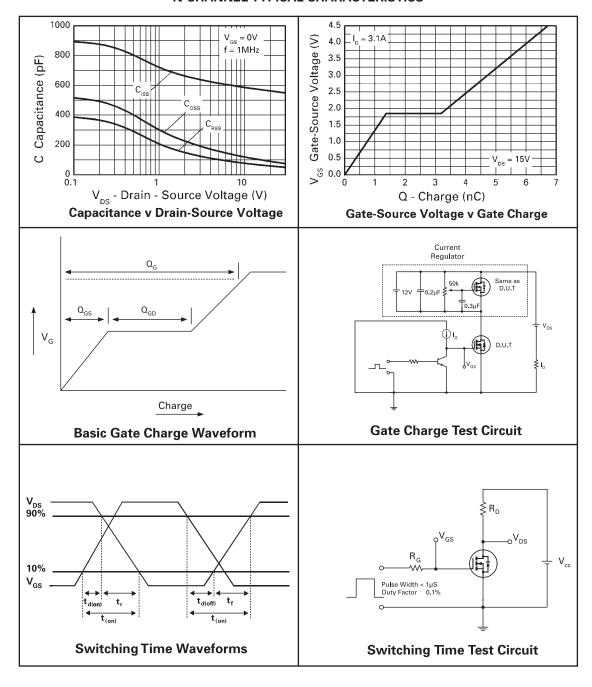


N-CHANNEL TYPICAL CHARACTERISTICS



ZETEX SEMICONDUCTORS

N-CHANNEL TYPICAL CHARACTERISTICS

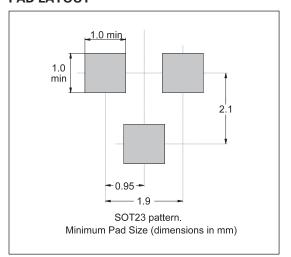




PACKAGE OUTLINE

3 LEADS D

PAD LAYOUT



Controlling dimensions are in millimetres. Approximate conversions are given in inches

PACKAGE DIMENSIONS

	MILLIN	IETRES	INC	HES		MILLIMETRES		INCHES	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
Α	2.67	3.05	0.105	0.120	Н	0.33	0.51	0.013	0.020
В	1.20	1.40	0.047	0.055	K	0.01	0.10	0.0004	0.004
С	_	1.10	_	0.043	L	2.10	2.50	0.083	0.0985
D	0.37	0.53	0.015	0.021	М	0.45	0.64	0.018	0.025
F	0.085	0.15	0.0034	0.0059	N	0.95 NOM		0.0375 NOM	
G	1.90	NOM	0.075	NOM	θ	10° TYP		10° TYP	

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